Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/000,232	SCHARF ET AL.
Examiner	**Art Unit**
James Phan	2872

SEARCHED			
Class	Subclass	Date	Examiner
359	205 208 212	8/05	J.P.
	223		
	226		
	572		
	742		
438	29,32		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST. See attachment	8/05	J.P.
	4/2/06	J.P.